

RoHS

COMPLIANT

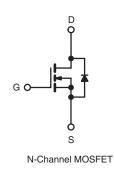
N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	60					
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	0.027				
Q _g (Max.) (nC)	95					
Q _{gs} (nC)	27					
Q _{gd} (nC)	46					
Configuration	Single					

FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available





ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	v	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	۱ _D	45		
	VGS at TO V	T _C = 100 °C		30	А	
Pulsed Drain Current ^a			I _{DM}	220		
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	100	mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	P _D 52		
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 129 \text{ }\mu\text{H}$, $R_G = 25 \Omega$, $I_{AS} = 30 \text{ A}$ (see fig. 12). c. $I_{SD} \leq 52 \text{ A}$, dI/dt $\leq 250 \text{ A}/\mu\text{s}$, $V_{DD} \leq V_{DS}$, $T_J \leq 175 \text{ °C}$.

d. 1.6 mm from case.



THERMAL RESISTANCE RAT	FINGS							
PARAMETER	SYMBOL	TYP	•	MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	- 65			0044		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	- 3.1			- °C/W		
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless otherv	vise noted						
PARAMETER	SYMBOL	TES		ONS	MIN.	TYP.	MAX.	UNIT
Static								-
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 μA	60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$			1.0	-	3.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V			-	-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} =	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	25	μΑ
	I _{DSS}	V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C			-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 18 A ^b	-	0.027	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 25 V, I _D =	18 A ^b	15	-	-	S
Dynamic								
Input Capacitance	C _{iss}		$V_{GS} = 0 V_{,}$		-	1500	-	
Output Capacitance	C _{oss}	f = 1.0 MHz		-	720	-	рF	
Reverse Transfer Capacitance	C _{rss}			-	100	-		
Drain to Sink Capacitance	С			-	12	-		
Total Gate Charge	Qg		$I_{\rm D} = 52$ A, $V_{\rm DS} = 48$ V,		-	-	95	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	27	nC	
Gate-Drain Charge	Q _{gd}		See ní	see fig. 6 and 13 ^b	-	-	46	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 30 V, I _D = 52 A, R _G = 9.1 Ω, R _D = 0.54 Ω, see fig. 10 ^b			-	19	-	
Rise Time	tr			-	120	-	- ns	
Turn-Off Delay Time	t _{d(off)}			-	55	-		
Fall Time	t _f			-	86	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	45	A	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode			-	-		120
Body Diode Voltage	V _{SD}	T _J = 25 °C	, I _S = 30 A,	$V_{GS} = 0 V^{b}$	-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T 25 °C I	- 52 A dl/	dt - 100 A/usb	-	140	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = 52 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}^b$		-	1.2	2.8	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						

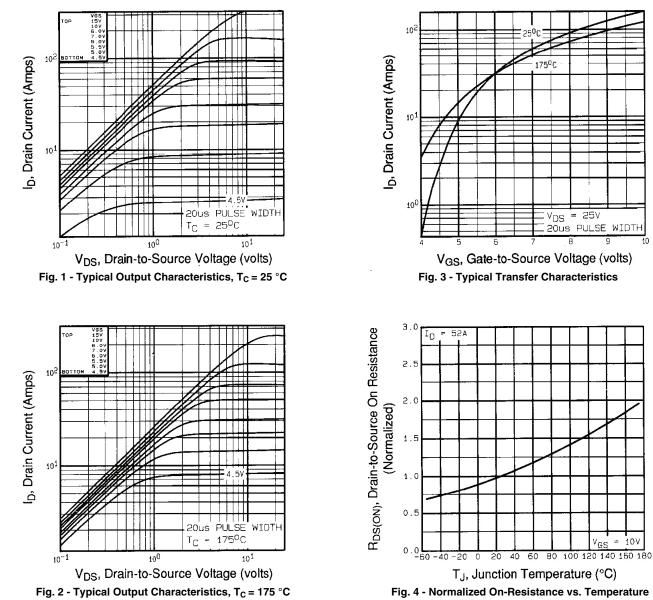
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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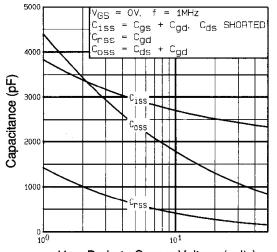
10V



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

FQPF30N06L





V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

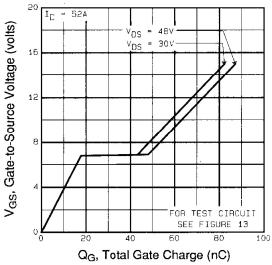


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

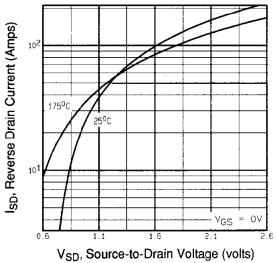
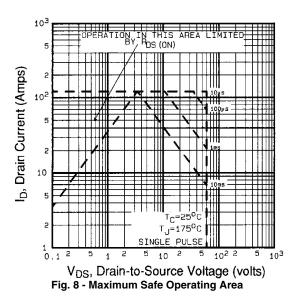


Fig. 7 - Typical Source-Drain Diode Forward Voltage



FQPF30N06L



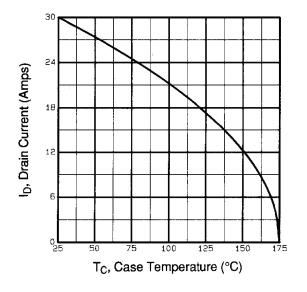


Fig. 9 - Maximum Drain Current vs. Case Temperature

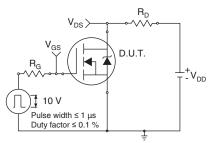


Fig. 10a - Switching Time Test Circuit

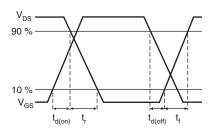


Fig. 10b - Switching Time Waveforms

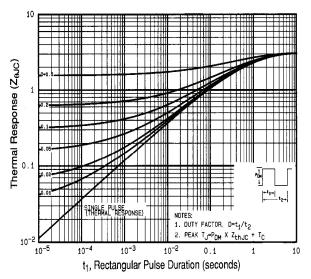
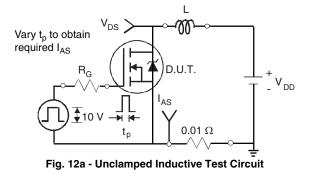


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



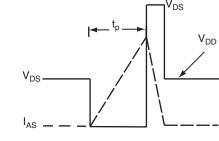
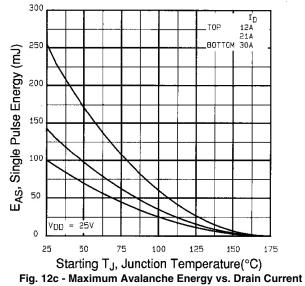
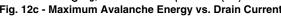


Fig. 12b - Unclamped Inductive Waveforms







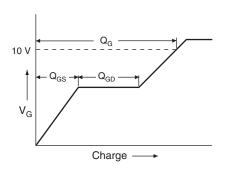
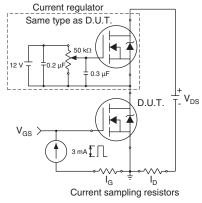
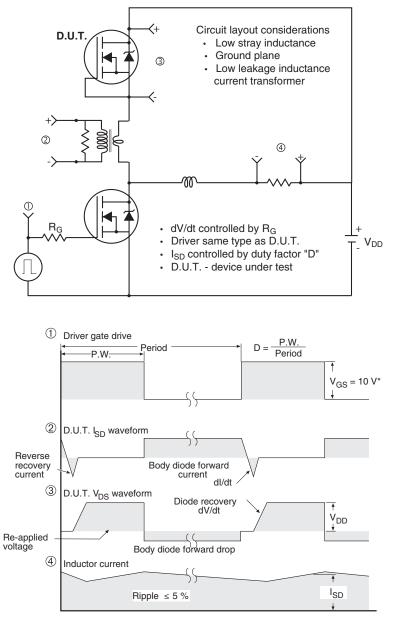


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel



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